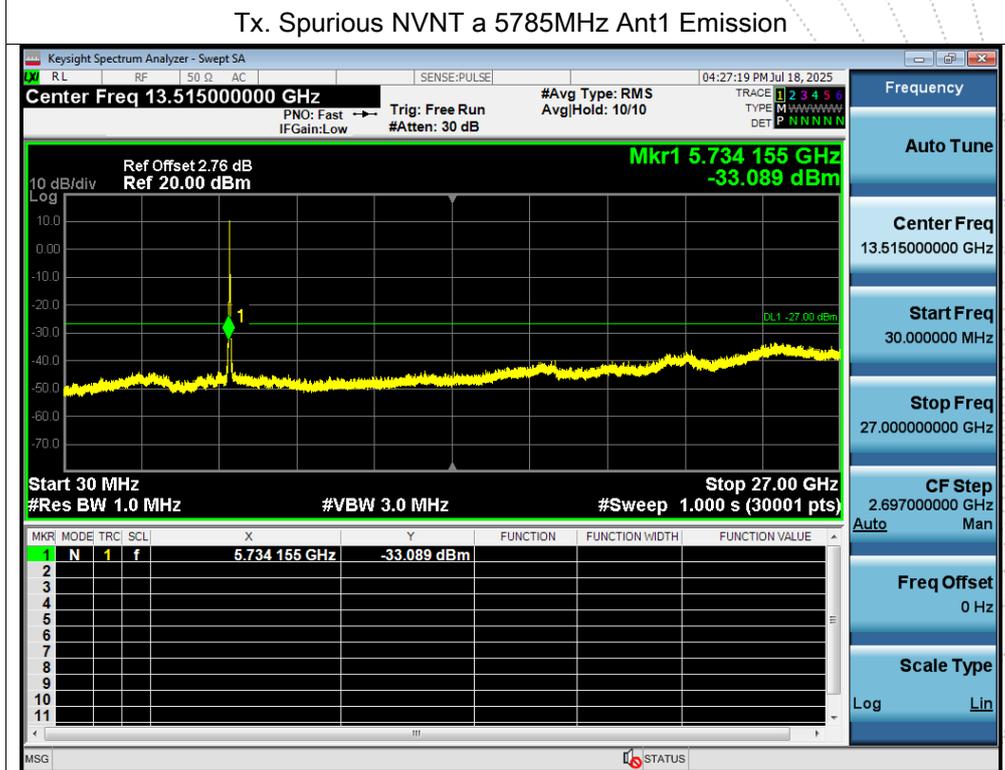
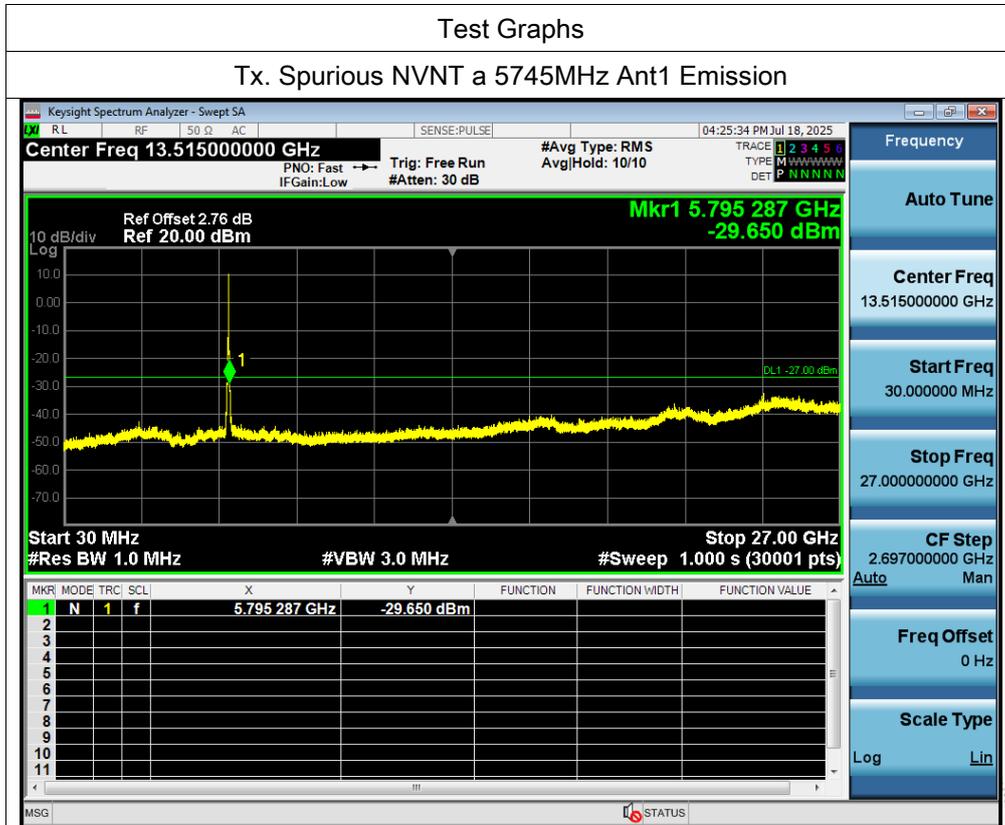
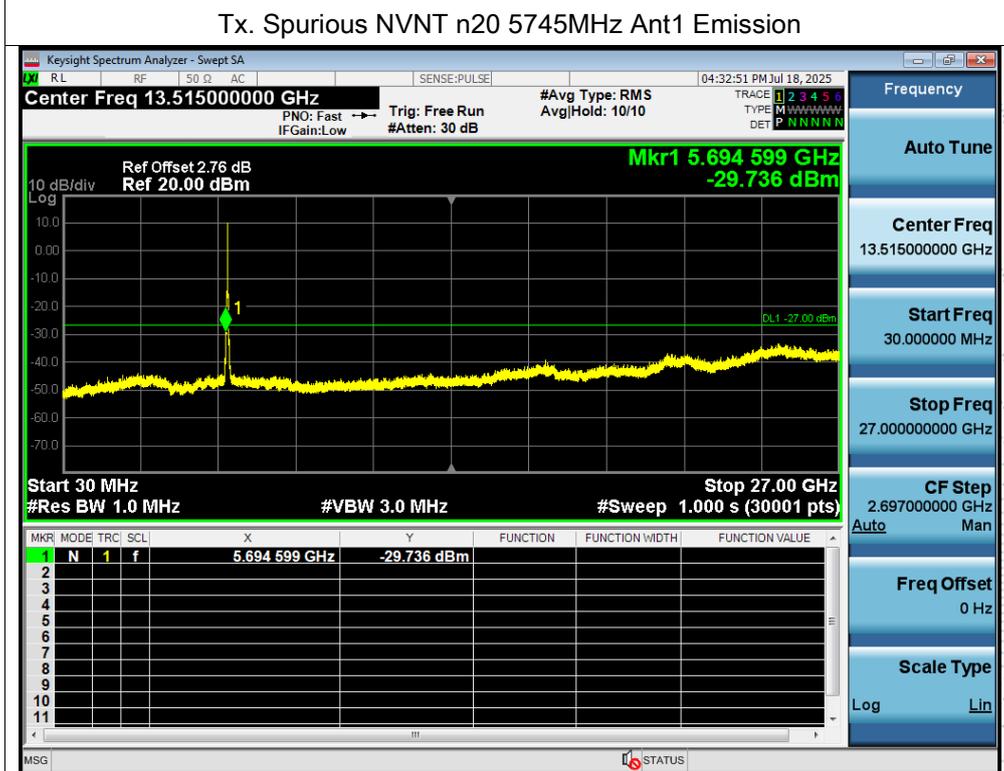
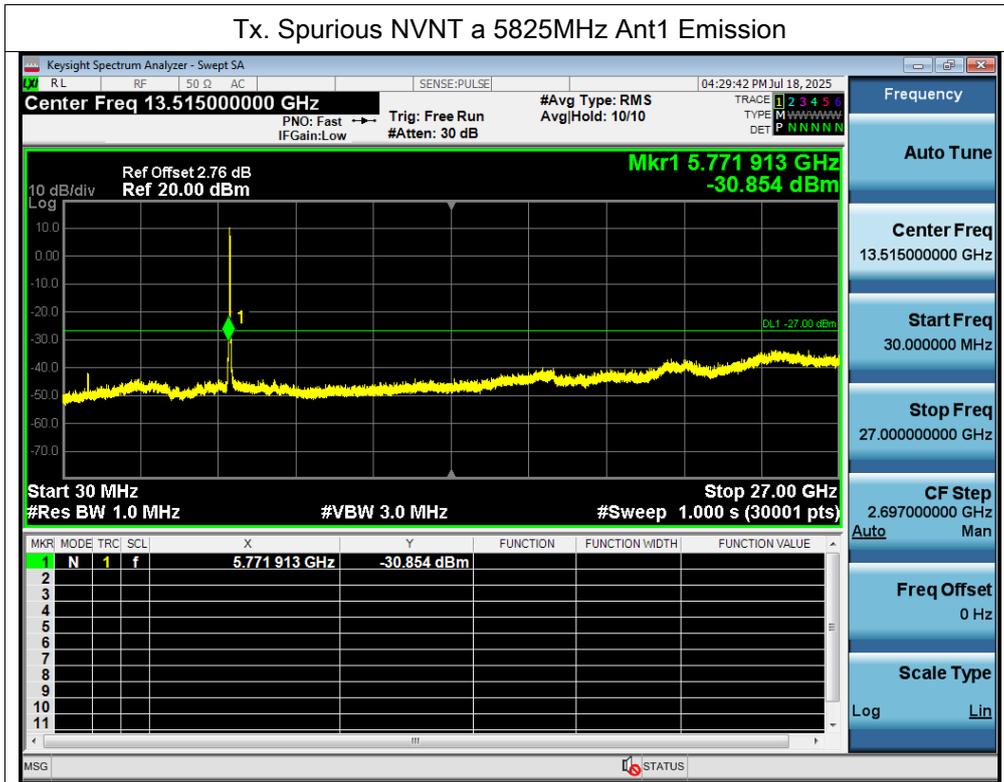
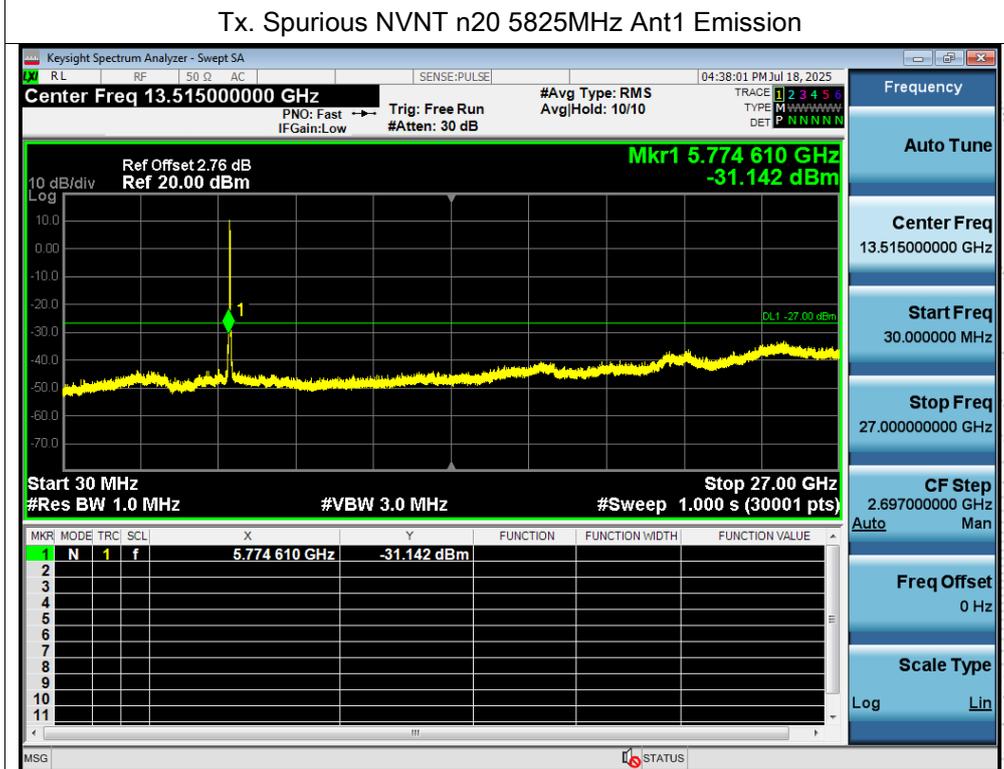
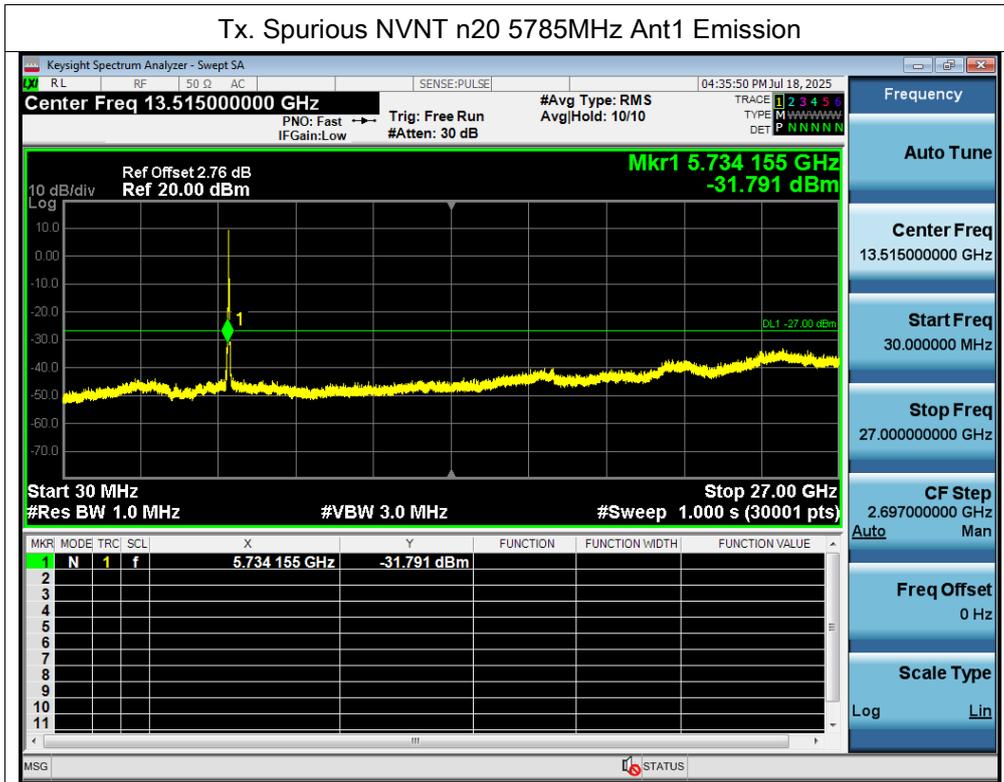
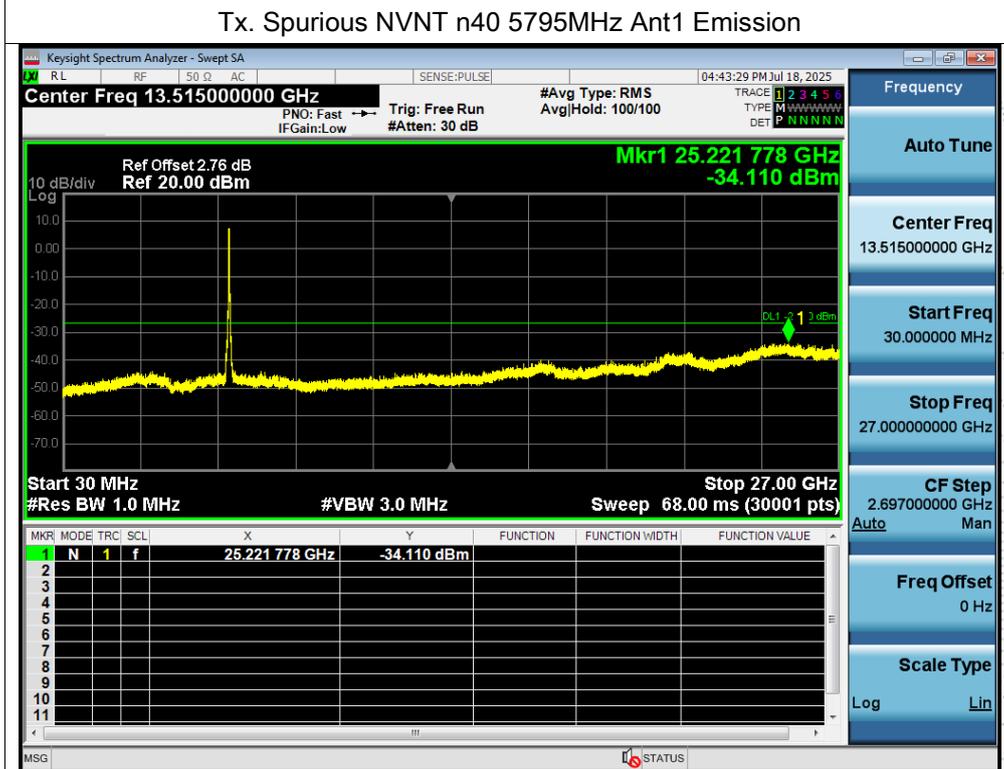
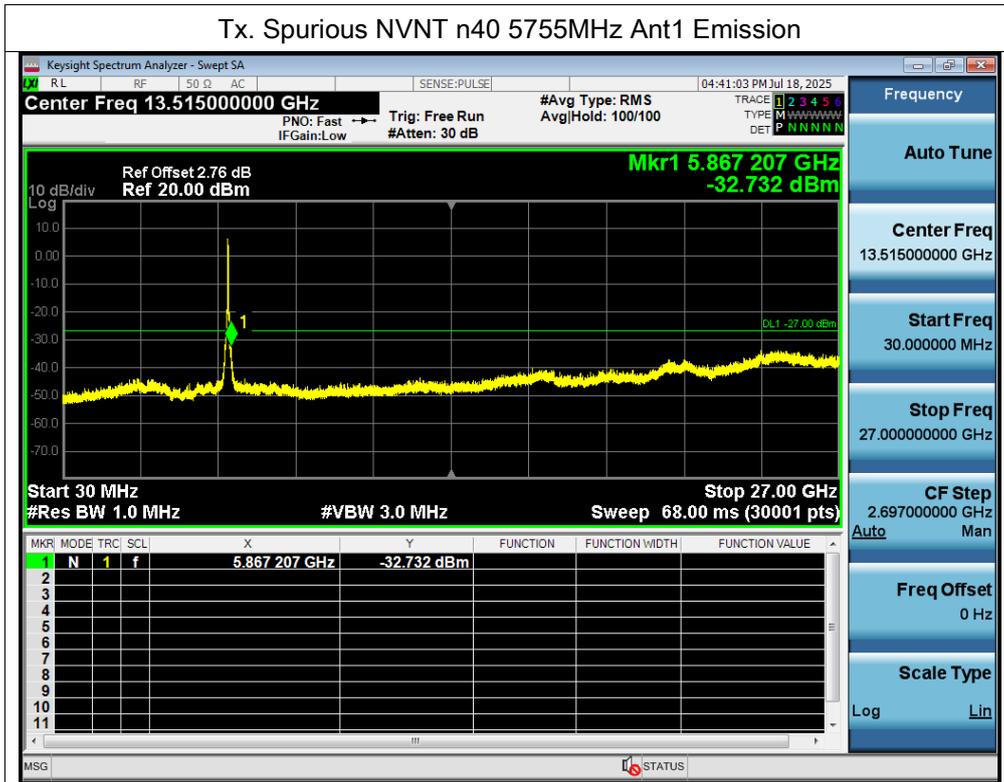


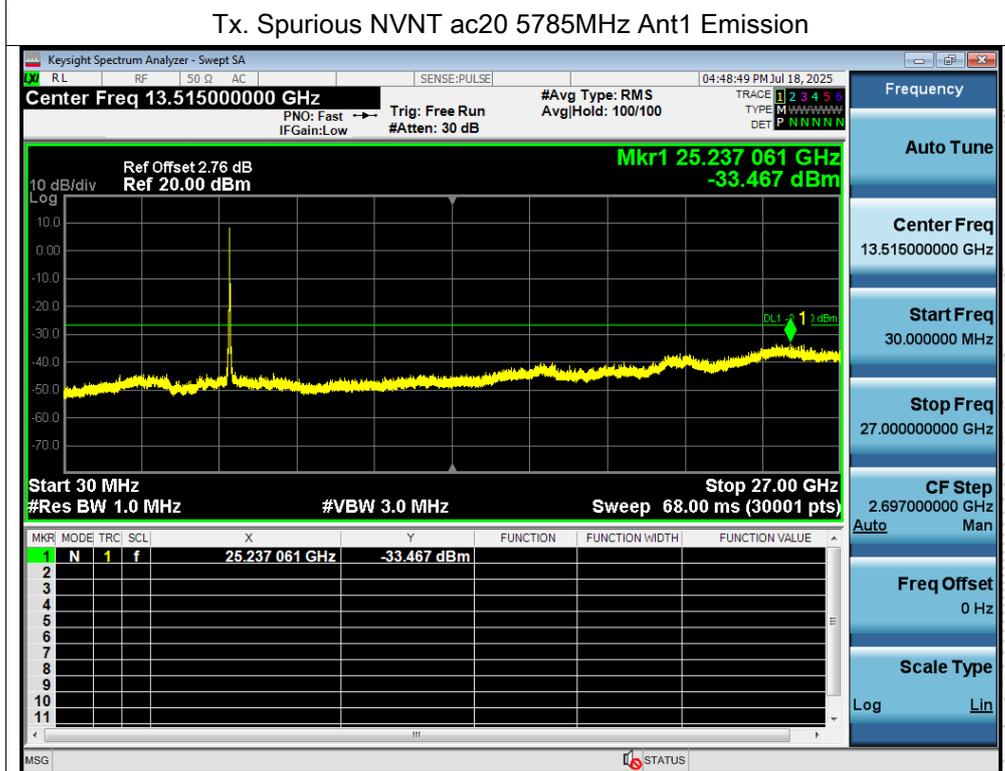
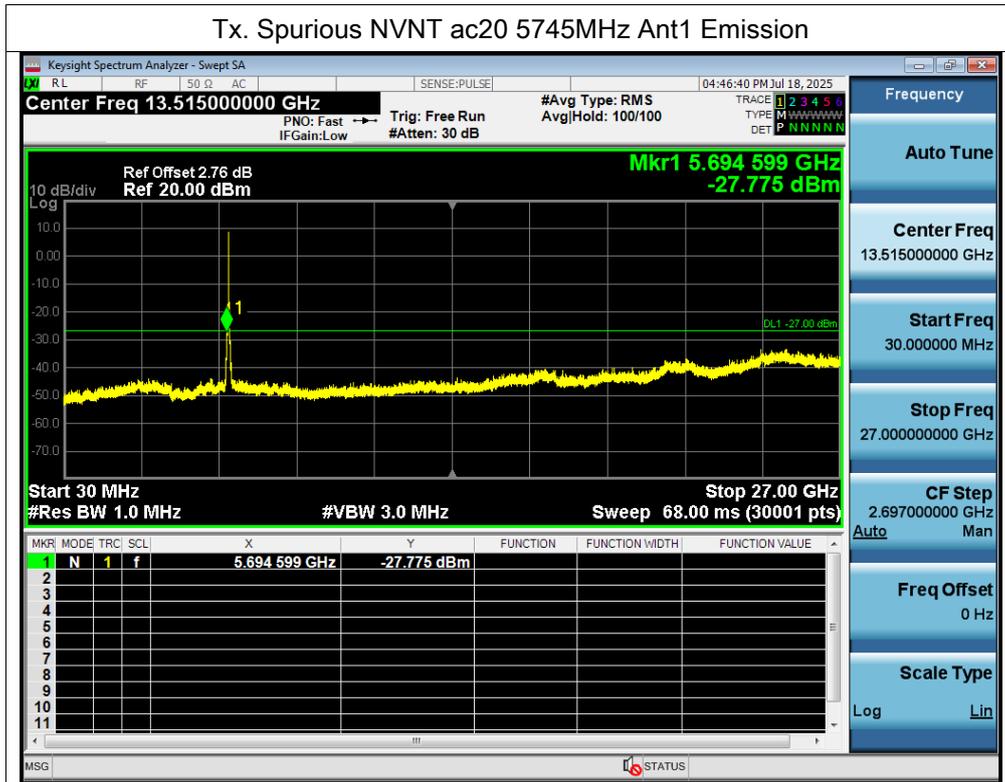
Note: A(B) Represent the value of antenna A and B, The worst data is Antenna A, only shown Antenna A.
 Antenna A: 5745-58250MHz



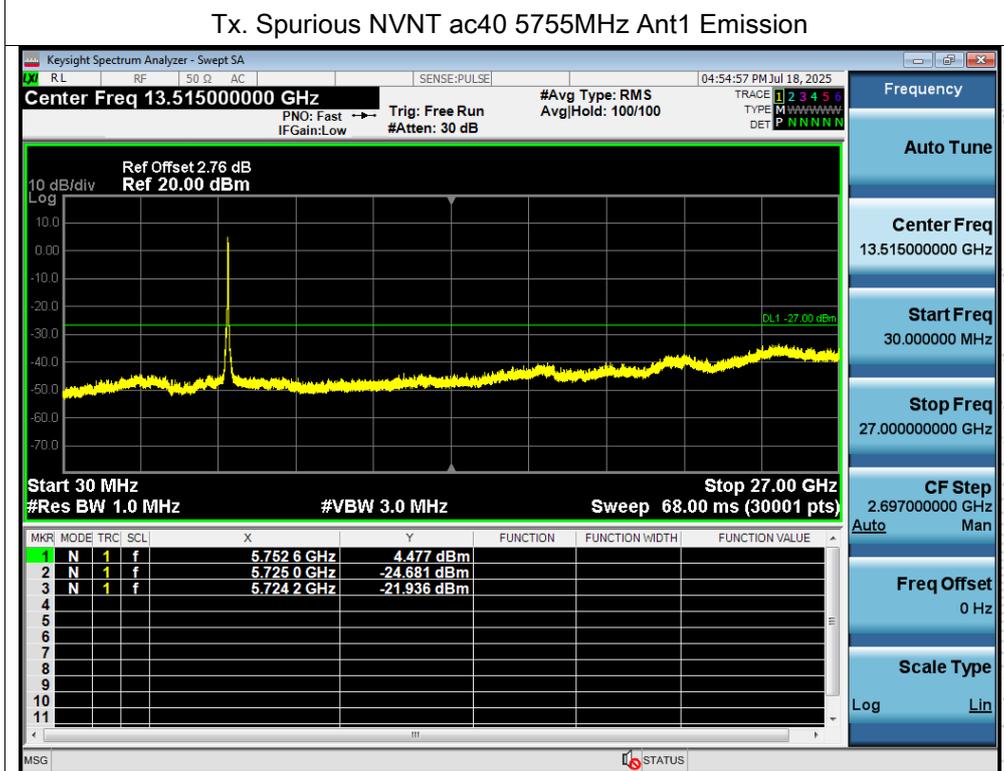
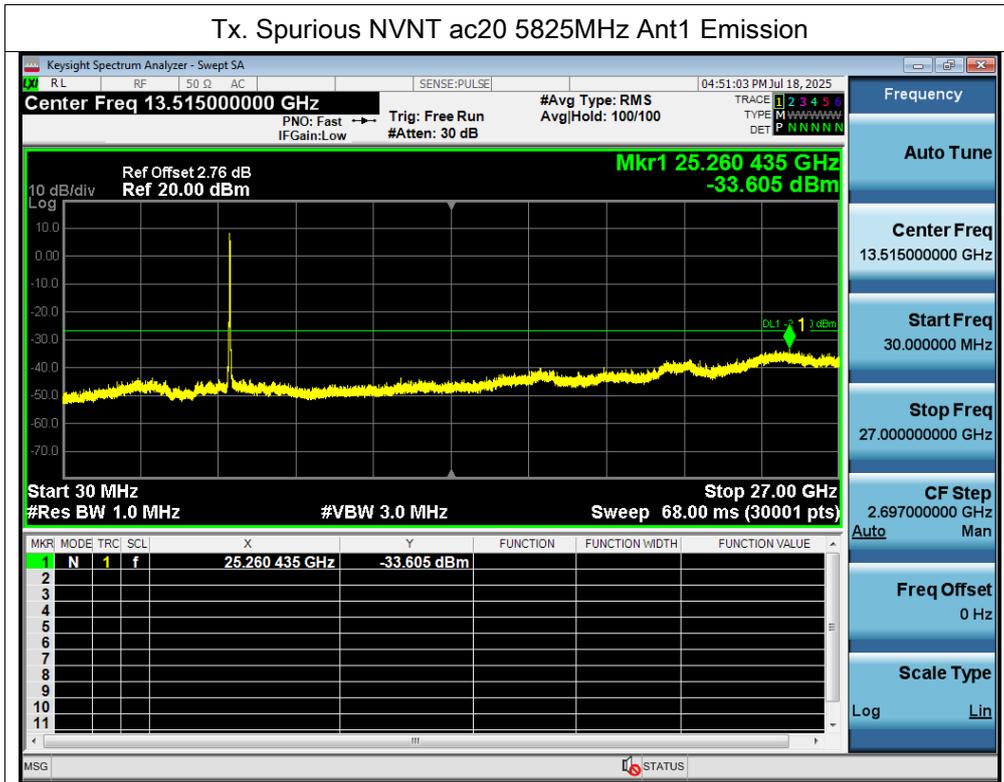


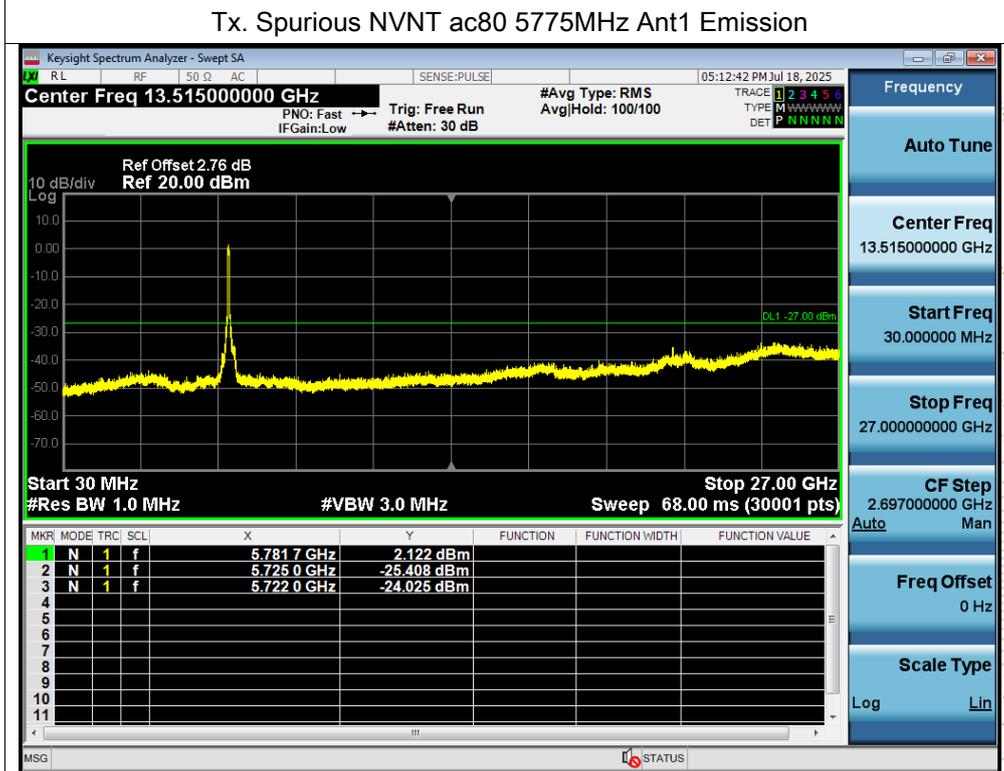
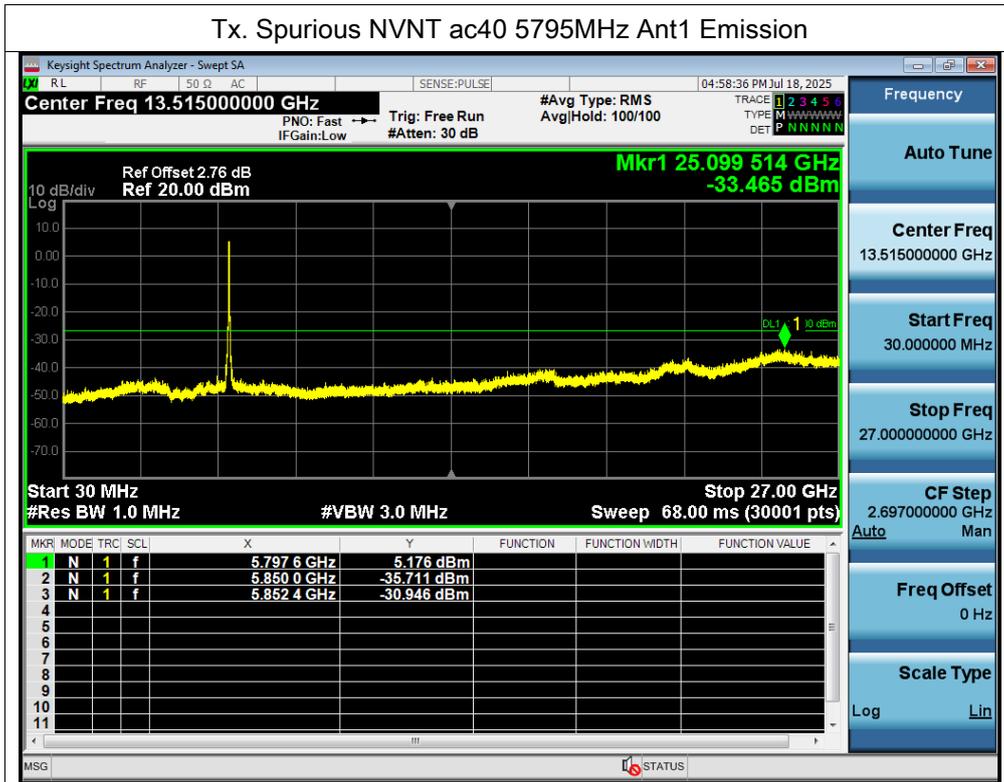


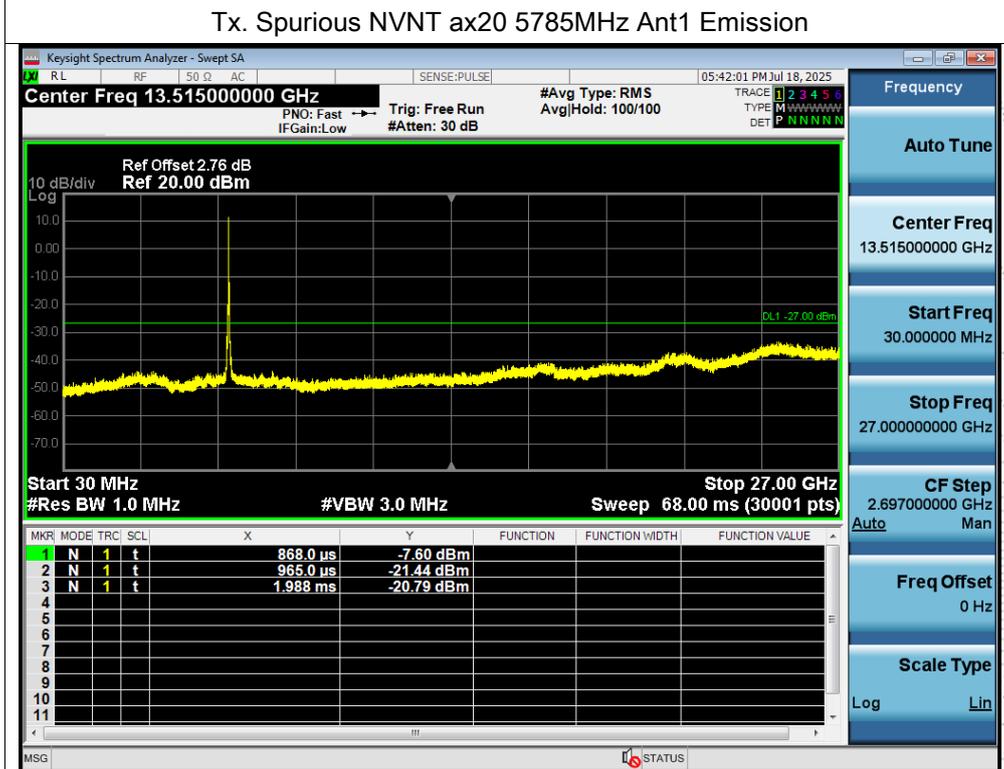
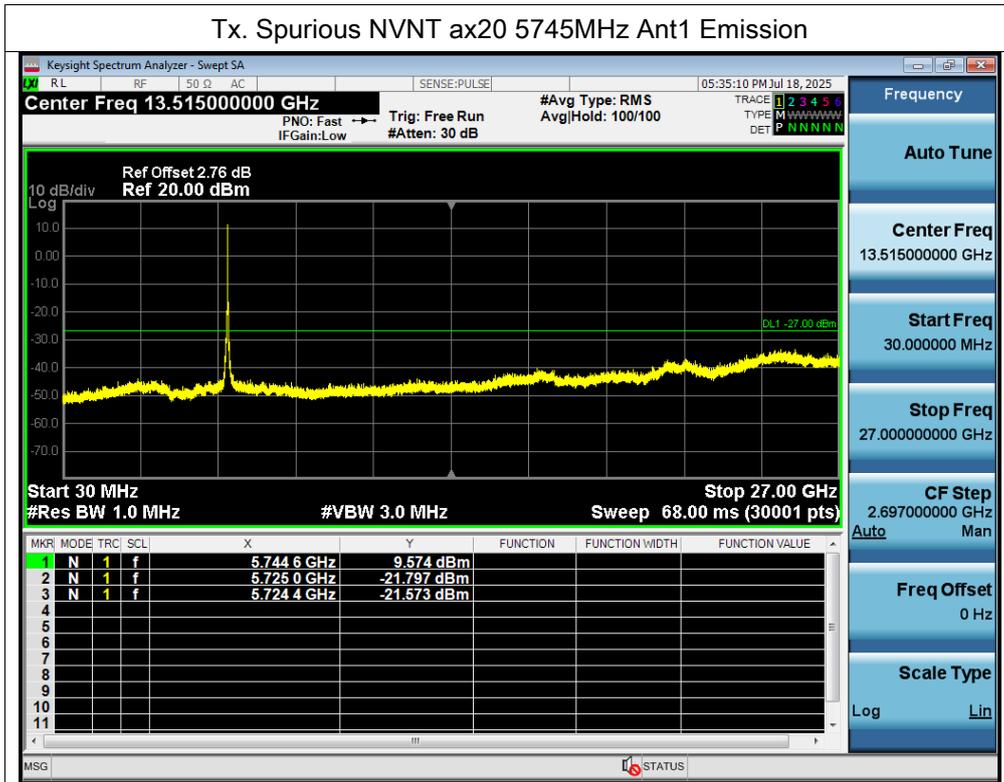


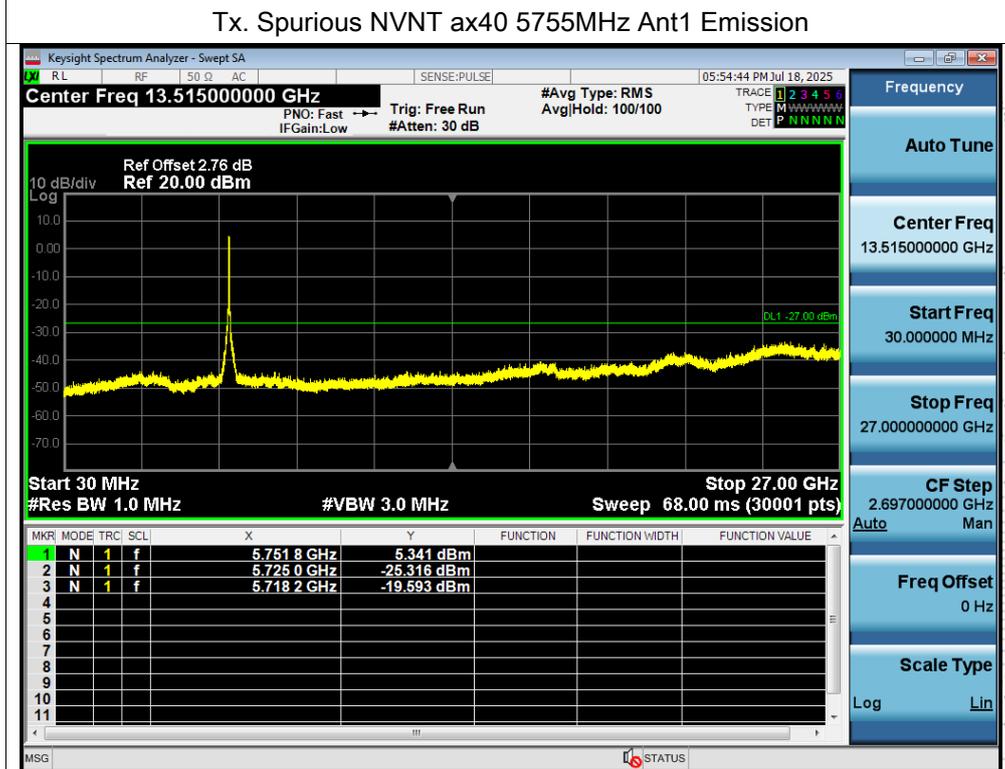
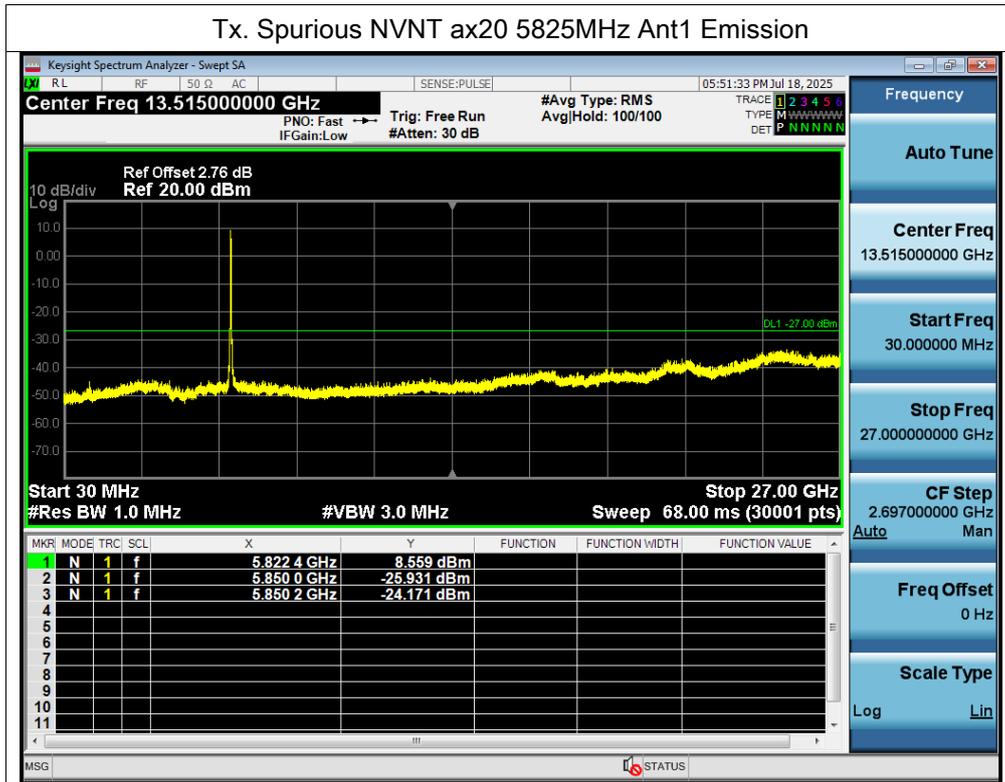


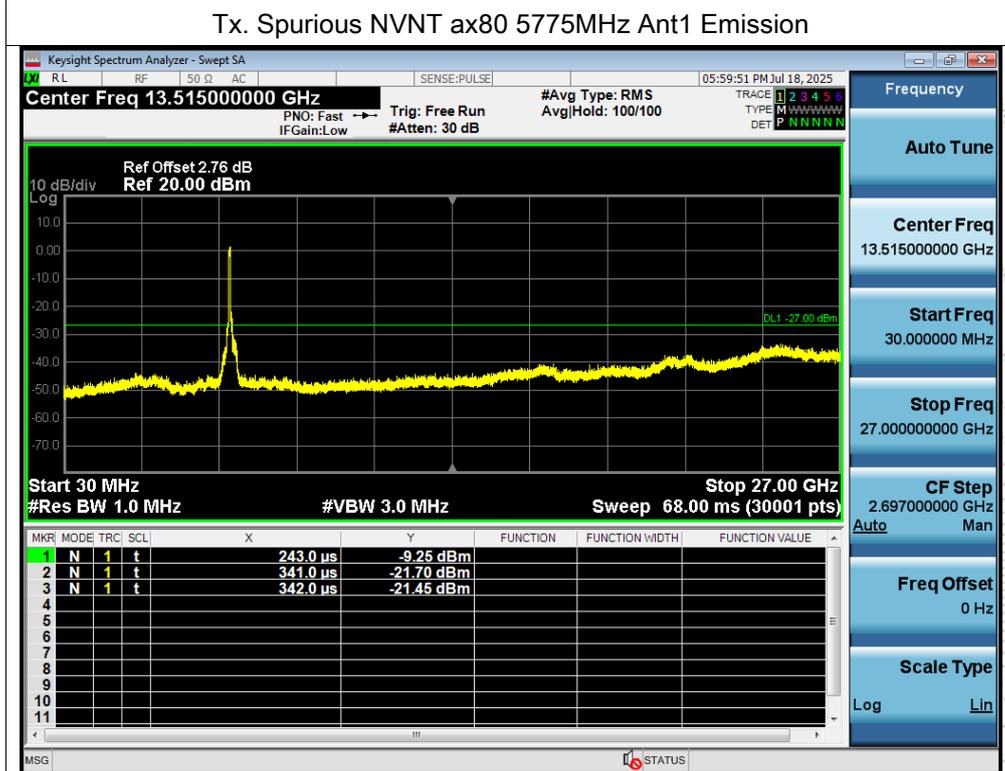
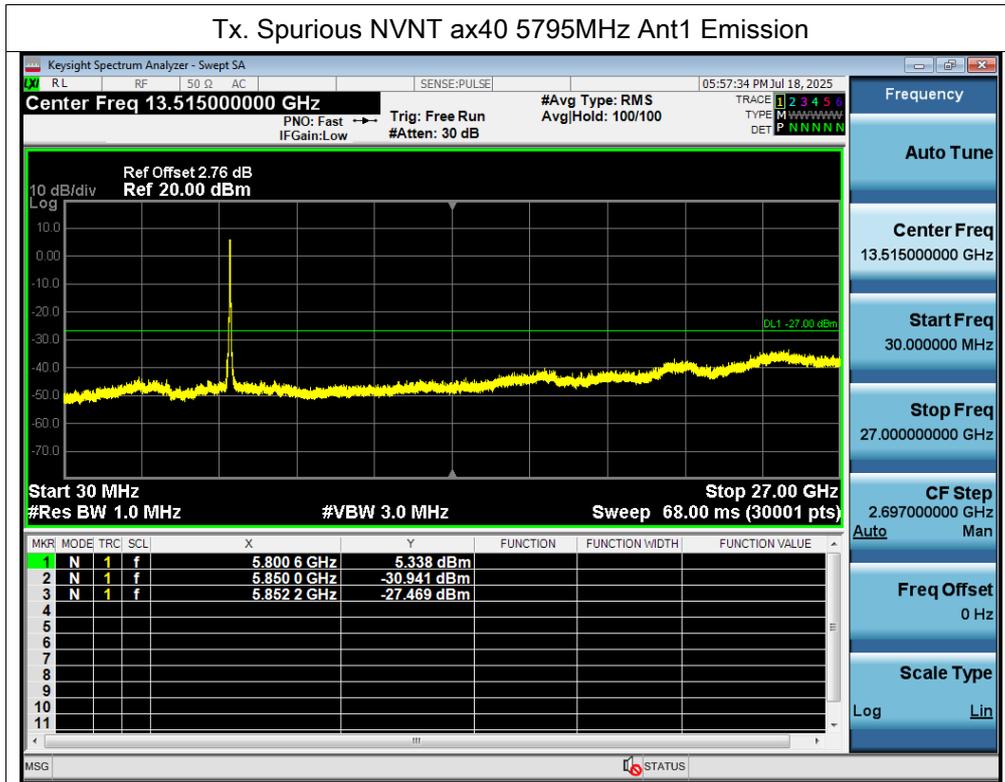
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13. Frequency Stability Measurement

13.1 Block Diagram Of Test Setup



13.2 Limit

Manufactures of U-NII devices are responsible for ensuring frequency stability such that an emission is maintained within the band of operation under all conditions of normal operation as specified in the user's manual.

The transmitter center frequency tolerance shall be ± 20 ppm maximum for the 5 GHz band (IEEE 802.11n specification)..

13.3 Test Procedure

1. The transmitter output (antenna port) was connected to the spectrum analyzer.
2. EUT have transmitted absence of modulation signal and fixed channelize.
3. Set the spectrum analyzer span to view the entire absence of modulation emissions bandwidth.
4. Set RBW = 10 kHz, VBW = 10 kHz with peak detector and maxhold settings.
5. f_c is declaring of channel frequency. Then the frequency error formula is $(f_c - f) / f_c \times 10^6$ ppm and he limit is less than ± 20 ppm (IEEE 802.11n specification).
6. The test extreme voltage is to change the primary supply voltage from 85 to 115 percent of the nominal value
7. Extreme temperature is $-20^\circ\text{C} \sim 70^\circ\text{C}$.

13.4 Test Result

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	DC 3.7V
Test Mode:	TX (5.1G) Mode Frequency U-NII-1 (5180-5240MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5180.0131	5180	0.0131	2.5342
		V max (V)	138.00	5180.0114	5180	0.0114	2.1984
		V min (V)	102.00	5180.0153	5180	0.0153	2.9507
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

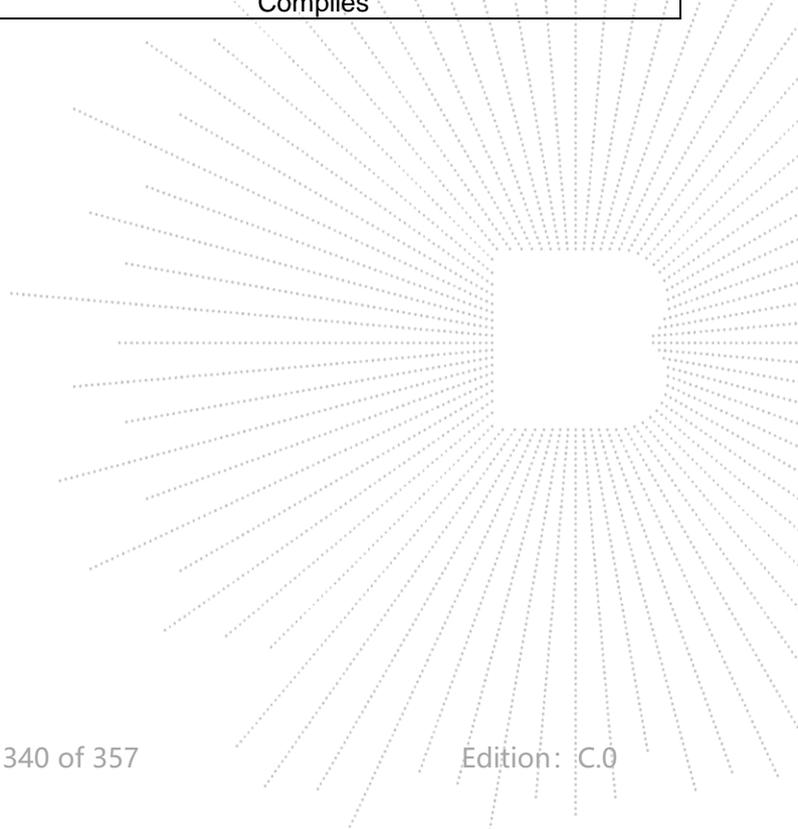
TEST CONDITIONS				Reference Frequency: 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5180.0022	5180	0.0022	0.4292
		T (°C)	-10	5180.0069	5180	0.0069	1.3353
		T (°C)	0	5180.0048	5180	0.0048	0.9316
		T (°C)	10	5180.0027	5180	0.0027	0.5142
		T (°C)	20	5180.0116	5180	0.0116	2.2347
		T (°C)	30	5180.0006	5180	0.0006	0.1082
		T (°C)	40	5180.0031	5180	0.0031	0.5952
		T (°C)	50	5180.0020	5180	0.0020	0.3781
		T (°C)	60	5180.0006	5180	0.0006	0.1105
		T (°C)	70	5180.0063	5180	0.0063	1.2116
Limits				5150-5250 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5200.0082	5200	0.0082	1.5852
		V max (V)	138.00	5200.0108	5200	0.0108	2.0825
		V min (V)	102.00	5200.0066	5200	0.0066	1.2637
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5200.00716	5200	0.00716	1.3766
		T (°C)	-10	5200.01047	5200	0.01047	2.0144
		T (°C)	0	5200.01040	5200	0.01040	1.9993
		T (°C)	10	5200.00644	5200	0.00644	1.2378
		T (°C)	20	5200.00651	5200	0.00651	1.2521
		T (°C)	30	5200.00178	5200	0.00178	0.3429
		T (°C)	40	5200.00347	5200	0.00347	0.6675
		T (°C)	50	5200.00831	5200	0.00831	1.5976
		T (°C)	60	5200.00659	5200	0.00659	1.2667
		T (°C)	70	5200.00327	5200	0.00327	0.6290
Limits				5150-5250 MHz			
Result				Complies			

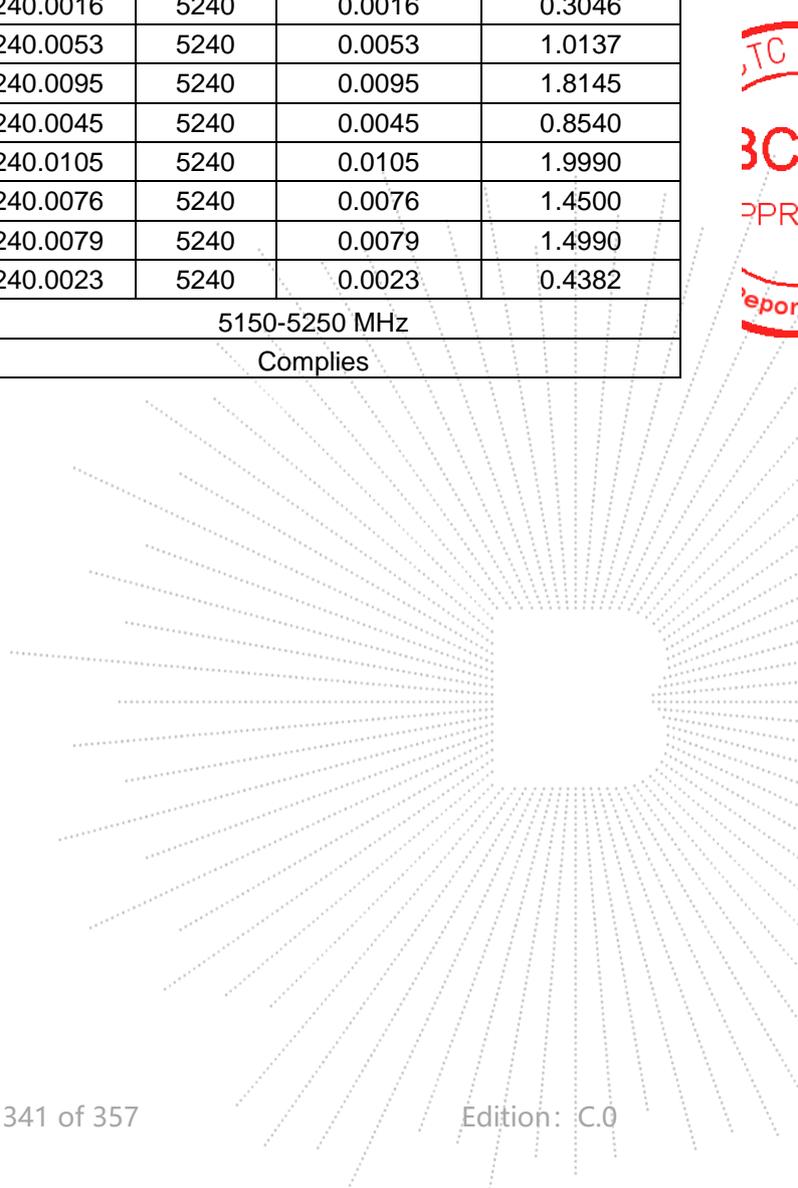


Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5240.0093	5240	0.0093	1.7738
		V max (V)	138.00	5240.0065	5240	0.0065	1.2445
		V min (V)	102.00	5240.0124	5240	0.0124	2.3584
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5240.0112	5240	0.0112	2.1396
		T (°C)	-10	5240.0071	5240	0.0071	1.3458
		T (°C)	0	5240.0016	5240	0.0016	0.3046
		T (°C)	10	5240.0053	5240	0.0053	1.0137
		T (°C)	20	5240.0095	5240	0.0095	1.8145
		T (°C)	30	5240.0045	5240	0.0045	0.8540
		T (°C)	40	5240.0105	5240	0.0105	1.9990
		T (°C)	50	5240.0076	5240	0.0076	1.4500
		T (°C)	60	5240.0079	5240	0.0079	1.4990
		T (°C)	70	5240.0023	5240	0.0023	0.4382
Limits				5150-5250 MHz			
Result				Complies			



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Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	DC 3.7V
Test Mode:	TX (5.3G) Mode Frequency U-NII-2A (5260-5320MHz)		

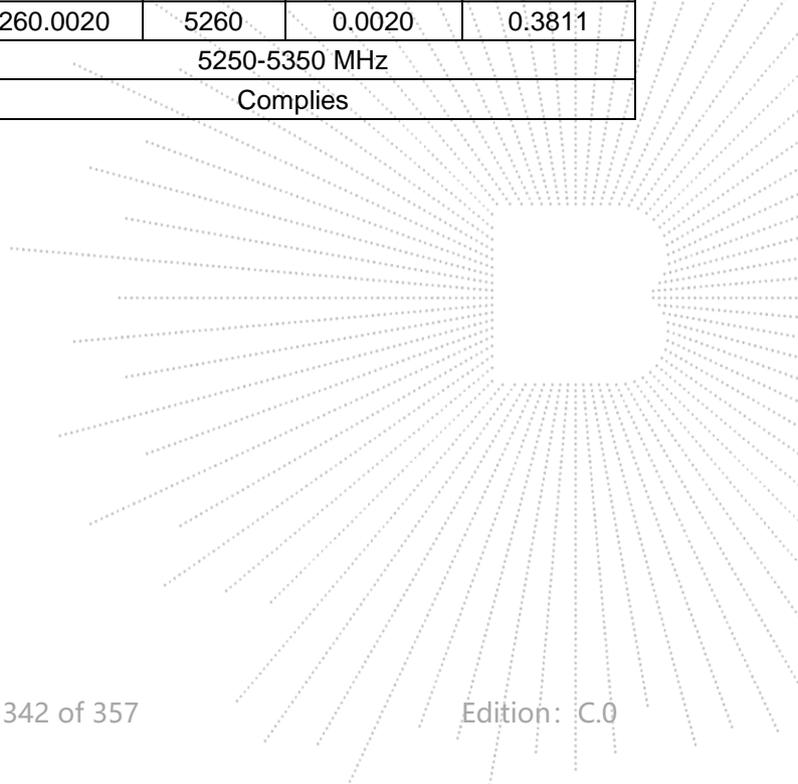
Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5260MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5260.0103	5260	0.0103	1.9595
		V max (V)	138.00	5260.0198	5260	0.0198	3.7596
		V min (V)	102.00	5260.0012	5260	0.0012	0.2286
Limits				5250-5350 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5260MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5260.0015	5260	0.0015	0.2859
		T (°C)	-10	5260.0049	5260	0.0049	0.9273
		T (°C)	0	5260.0118	5260	0.0118	2.2524
		T (°C)	10	5260.0054	5260	0.0054	1.0243
		T (°C)	20	5260.0017	5260	0.0017	0.3235
		T (°C)	30	5260.0106	5260	0.0106	2.0237
		T (°C)	40	5260.0016	5260	0.0016	0.3091
		T (°C)	50	5260.0064	5260	0.0064	1.2245
		T (°C)	60	5260.0096	5260	0.0096	1.8341
		T (°C)	70	5260.0020	5260	0.0020	0.3811
Limits				5250-5350 MHz			
Result				Complies			

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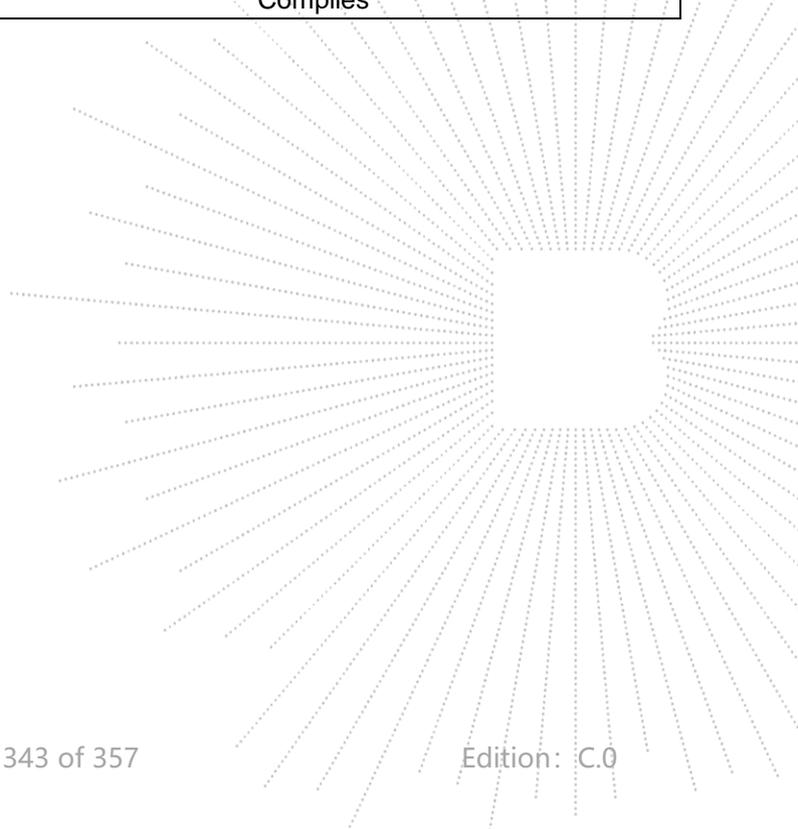


Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5280MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5280.0105	5280	0.0105	1.9928
		V max (V)	138.00	5280.0077	5280	0.0077	1.4647
		V min (V)	102.00	5280.0056	5280	0.0056	1.0648
Limits				5250-5350 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5280MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5280.00859	5280	0.00859	1.6278
		T (°C)	-10	5280.00354	5280	0.00354	0.6699
		T (°C)	0	5280.01157	5280	0.01157	2.1911
		T (°C)	10	5280.00238	5280	0.00238	0.4505
		T (°C)	20	5280.00389	5280	0.00389	0.7364
		T (°C)	30	5280.01250	5280	0.01250	2.3680
		T (°C)	40	5280.00911	5280	0.00911	1.7256
		T (°C)	50	5280.00530	5280	0.00530	1.0045
		T (°C)	60	5280.01180	5280	0.01180	2.2350
		T (°C)	70	5280.00649	5280	0.00649	1.2296
Limits				5250-5350 MHz			
Result				Complies			

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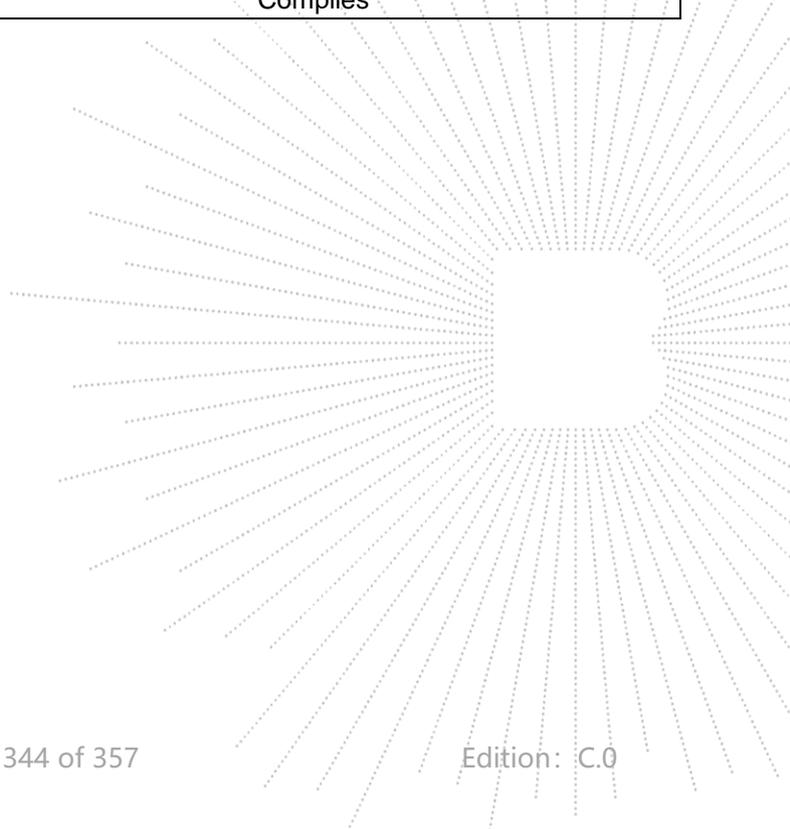
Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5320MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5320.0053	5320	0.0053	0.9916
		V max (V)	138.00	5320.0000	5320	0.0000	0.0083
		V min (V)	102.00	5320.0055	5320	0.0055	1.0343
Limits				5250-5350 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5320MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5320.0004	5320	0.0004	0.0705
		T (°C)	-10	5320.0073	5320	0.0073	1.3704
		T (°C)	0	5320.0033	5320	0.0033	0.6135
		T (°C)	10	5320.0112	5320	0.0112	2.1074
		T (°C)	20	5320.0070	5320	0.0070	1.3086
		T (°C)	30	5320.0092	5320	0.0092	1.7239
		T (°C)	40	5320.0012	5320	0.0012	0.2183
		T (°C)	50	5320.0054	5320	0.0054	1.0074
		T (°C)	60	5320.0058	5320	0.0058	1.0831
		T (°C)	70	5320.0039	5320	0.0039	0.7408
Limits				5250-5350 MHz			
Result				Complies			

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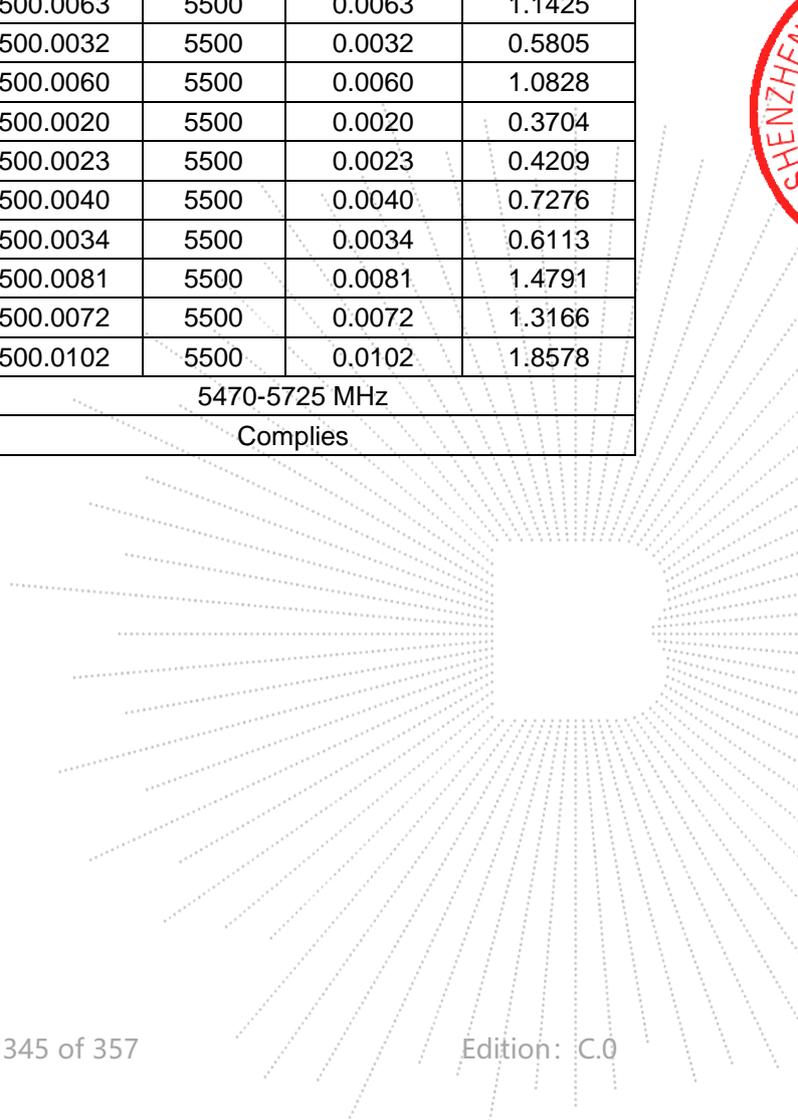
Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	DC 3.7V
Test Mode:	TX (5.6G) Mode Frequency U-NII-2C (5500-5700MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5500MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5500.0028	5500	0.0028	0.5095
		V max (V)	138.00	5500.0144	5500	0.0144	2.6119
		V min (V)	102.00	5500.0017	5500	0.0017	0.3084
Limits				5470-5725 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5500MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5500.0063	5500	0.0063	1.1425
		T (°C)	-10	5500.0032	5500	0.0032	0.5805
		T (°C)	0	5500.0060	5500	0.0060	1.0828
		T (°C)	10	5500.0020	5500	0.0020	0.3704
		T (°C)	20	5500.0023	5500	0.0023	0.4209
		T (°C)	30	5500.0040	5500	0.0040	0.7276
		T (°C)	40	5500.0034	5500	0.0034	0.6113
		T (°C)	50	5500.0081	5500	0.0081	1.4791
		T (°C)	60	5500.0072	5500	0.0072	1.3166
		T (°C)	70	5500.0102	5500	0.0102	1.8578
Limits				5470-5725 MHz			
Result				Complies			

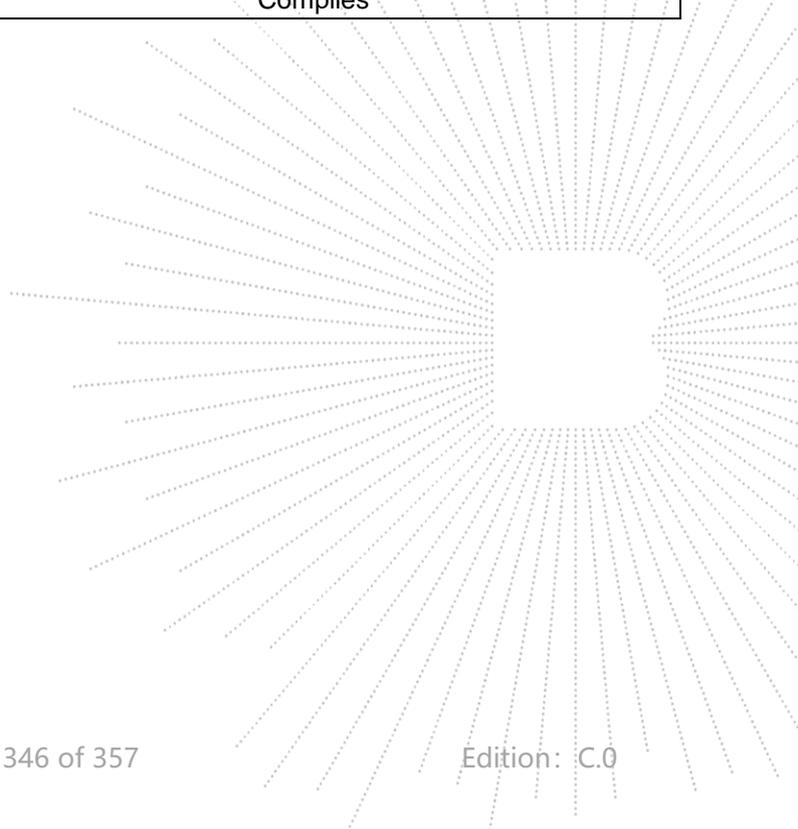


Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5580MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5580.0082	5580	0.0082	1.4688
		V max (V)	138.00	5580.0073	5580	0.0073	1.3133
		V min (V)	102.00	5580.0012	5580	0.0012	0.2146
Limits				5470-5725 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5580MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5580.01245	5580	0.01245	2.2309
		T (°C)	-10	5580.01246	5580	0.01246	2.2325
		T (°C)	0	5580.00233	5580	0.00233	0.4174
		T (°C)	10	5580.01027	5580	0.01027	1.8398
		T (°C)	20	5580.01021	5580	0.01021	1.8289
		T (°C)	30	5580.00157	5580	0.00157	0.2805
		T (°C)	40	5580.00312	5580	0.00312	0.5600
		T (°C)	50	5580.00841	5580	0.00841	1.5072
		T (°C)	60	5580.00103	5580	0.00103	0.1854
		T (°C)	70	5580.00416	5580	0.00416	0.7454
Limits				5470-5725 MHz			
Result				Complies			

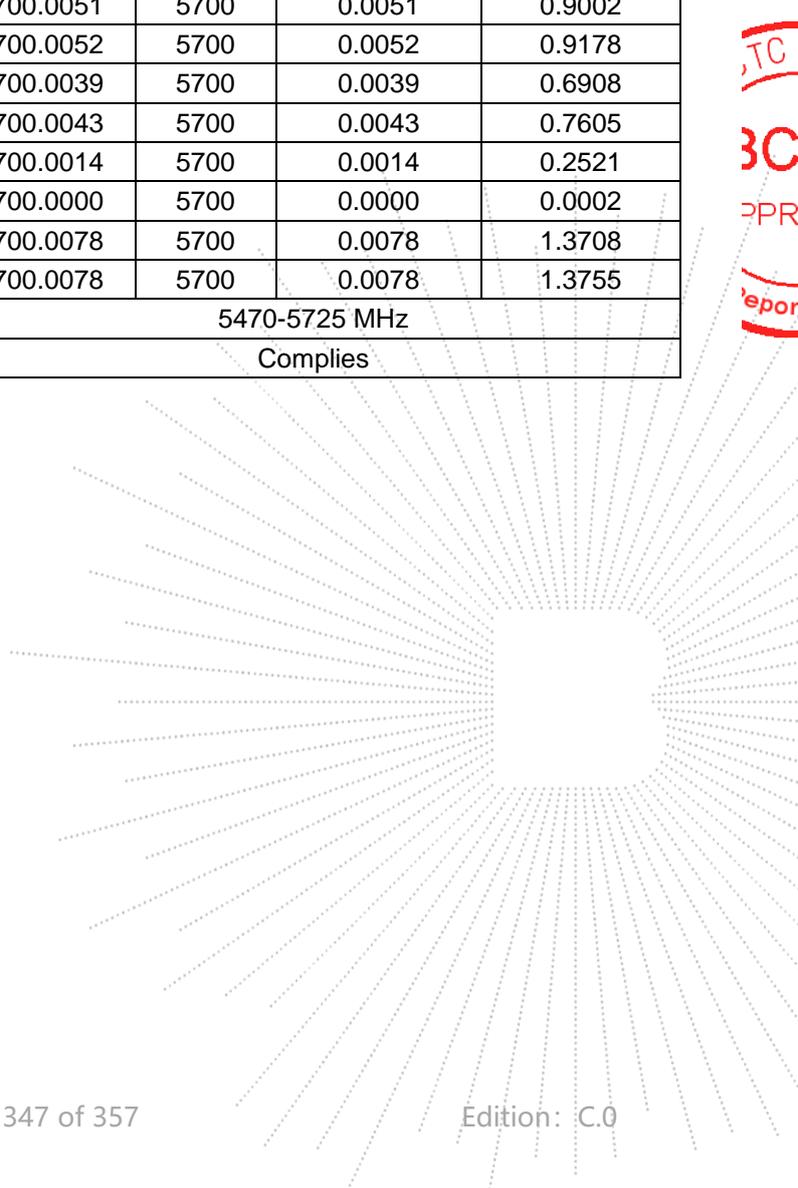


Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5700MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5700.0031	5700	0.0031	0.5512
		V max (V)	138.00	5700.0023	5700	0.0023	0.4073
		V min (V)	102.00	5700.0112	5700	0.0112	1.9596
Limits				5470-5725 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5700MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5700.0104	5700	0.0104	1.8214
		T (°C)	-10	5700.0134	5700	0.0134	2.3596
		T (°C)	0	5700.0051	5700	0.0051	0.9002
		T (°C)	10	5700.0052	5700	0.0052	0.9178
		T (°C)	20	5700.0039	5700	0.0039	0.6908
		T (°C)	30	5700.0043	5700	0.0043	0.7605
		T (°C)	40	5700.0014	5700	0.0014	0.2521
		T (°C)	50	5700.0000	5700	0.0000	0.0002
		T (°C)	60	5700.0078	5700	0.0078	1.3708
		T (°C)	70	5700.0078	5700	0.0078	1.3755
Limits				5470-5725 MHz			
Result				Complies			



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Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	DC 3.7V
Test Mode:	TX (5.8G) Mode Frequency U-NII-3 (5745-5825MHz)		

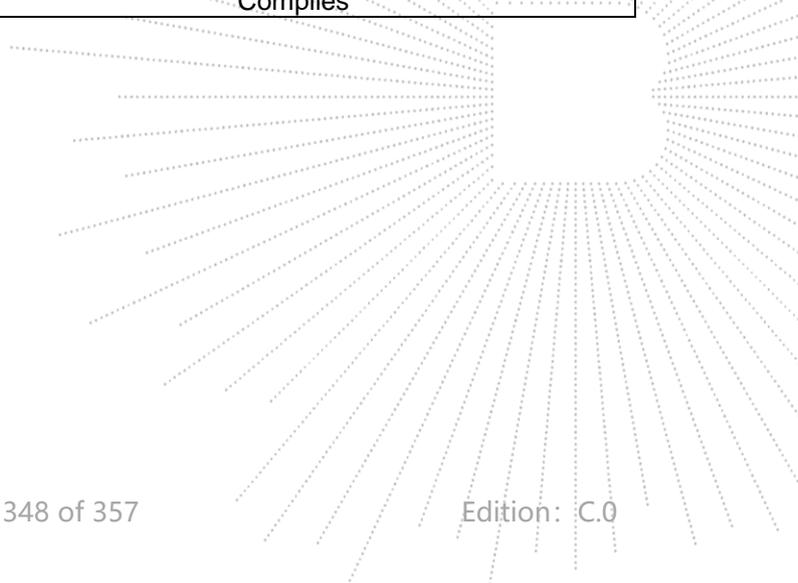
Voltage vs. Frequency Stabilit

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5745.00007	5745	0.00007	0.0124
		V max (V)	138.00	5745.00310	5745	0.00310	0.5397
		V min (V)	102.00	5745.00553	5745	0.00553	0.9631
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5745.00916	5745	0.00916	1.5939
		T (°C)	-10	5745.00961	5745	0.00961	1.6723
		T (°C)	0	5745.00659	5745	0.00659	1.1468
		T (°C)	10	5745.00819	5745	0.00819	1.4251
		T (°C)	20	5745.00920	5745	0.00920	1.6008
		T (°C)	30	5745.00402	5745	0.00402	0.6999
		T (°C)	40	5745.00996	5745	0.00996	1.7332
		T (°C)	50	5745.00651	5745	0.00651	1.1332
		T (°C)	60	5745.00194	5745	0.00194	0.3374
		T (°C)	70	5745.00407	5745	0.00407	0.7083
Limits				5725-5850 MHz			
Result				Complies			

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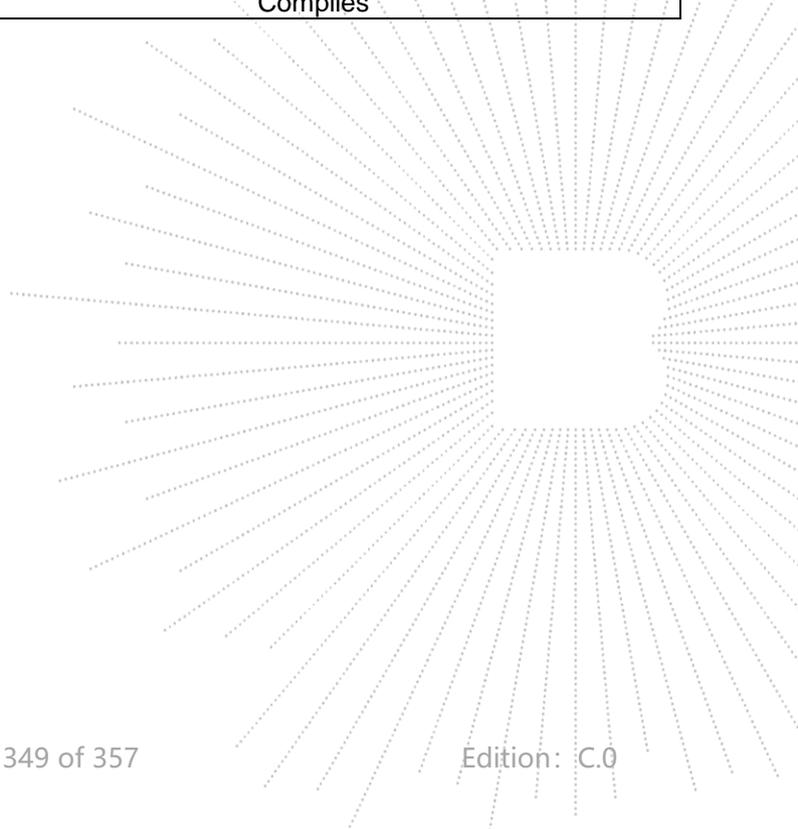


Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5785.00156	5785	0.00156	0.2699
		V max (V)	138.00	5785.00030	5785	0.00030	0.0510
		V min (V)	102.00	5785.01028	5785	0.01028	1.7769
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5785.00342	5785	0.00342	0.5903
		T (°C)	-10	5785.01201	5785	0.01201	2.0752
		T (°C)	0	5785.01295	5785	0.01295	2.2392
		T (°C)	10	5785.00064	5785	0.00064	0.1105
		T (°C)	20	5785.00486	5785	0.00486	0.8394
		T (°C)	30	5785.00479	5785	0.00479	0.8276
		T (°C)	40	5785.01070	5785	0.01070	1.8491
		T (°C)	50	5785.00402	5785	0.00402	0.6947
		T (°C)	60	5785.00114	5785	0.00114	0.1976
		T (°C)	70	5785.00385	5785	0.00385	0.6659
Limits				5725-5850 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	120.00	5825.00352	5825	0.00352	0.6046
		V max (V)	138.00	5825.00450	5825	0.00450	0.7720
		V min (V)	102.00	5825.00452	5825	0.00452	0.7758
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	120	T (°C)	-20	5825.00966	5825	0.00966	1.6590
		T (°C)	-10	5825.01031	5825	0.01031	1.7703
		T (°C)	0	5825.00870	5825	0.00870	1.4930
		T (°C)	10	5825.01351	5825	0.01351	2.3196
		T (°C)	20	5825.00383	5825	0.00383	0.6568
		T (°C)	30	5825.01044	5825	0.01044	1.7931
		T (°C)	40	5825.00111	5825	0.00111	0.1910
		T (°C)	50	5825.01232	5825	0.01232	2.1142
		T (°C)	60	5825.00876	5825	0.00876	1.5037
		T (°C)	70	5825.00513	5825	0.00513	0.8806
Limits				5725-5850 MHz			
Result				Complies			

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14. Duty Cycle Of Test Signal

14.1 Standard Requirement

Pre-analysis Check: While conducting average power measurement, duty cycle of each mode shall be checked to ensure its duty cycle in order to compensate for the loss due to insufficient ratio of duty cycle. All duty cycle is pre-scanned, and result as obtained below shows only the most representative ones where duty cycle is conducted as the given transmission with given virtual operation that expresses the percentage.

14.2 Formula

Duty Cycle = $T_{on} / (T_{on} + T_{off})$

14.3 Test Procedure

1. Set span = Zero
2. RBW = 8MHz
3. VBW = 8MHz,
4. Detector = Peak

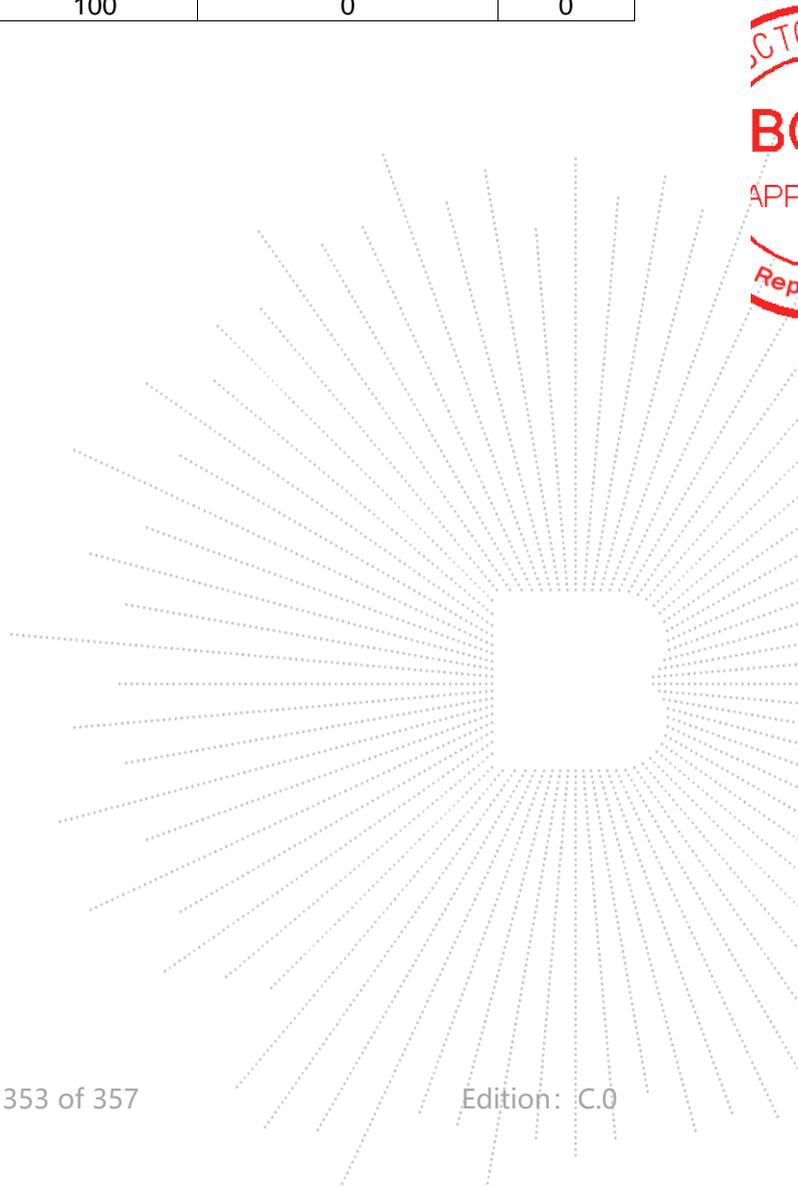
14.4 Test Result

Condition	Mode	Frequency (MHz)	Antenna	Duty Cycle (%)	Correction Factor (dB)	1/T (kHz)
NVNT	a	5180	AntA	100	0	0
NVNT	a	5200	AntA	100	0	0
NVNT	a	5240	AntA	100	0	0
NVNT	n20	5180	AntA	100	0	0
NVNT	n20	5200	AntA	100	0	0
NVNT	n20	5240	AntA	100	0	0
NVNT	n40	5190	AntA	100	0	0
NVNT	n40	5230	AntA	100	0	0
NVNT	ac20	5180	AntA	100	0	0
NVNT	ac20	5200	AntA	100	0	0
NVNT	ac20	5240	AntA	100	0	0
NVNT	ac40	5190	AntA	100	0	0
NVNT	ac40	5230	AntA	100	0	0
NVNT	ac80	5210	AntA	100	0	0
NVNT	ax20	5180	AntA	100	0	0
NVNT	ax20	5200	AntA	100	0	0
NVNT	ax20	5240	AntA	100	0	0
NVNT	ax40	5190	AntA	100	0	0
NVNT	ax40	5230	AntA	100	0	0
NVNT	ax80	5210	AntA	100	0	0

Condition	Mode	Frequency (MHz)	Antenna	Duty Cycle (%)	Correction Factor (dB)	1/T (kHz)
NVNT	a	5260	AntA	100	0	0
NVNT	a	5280	AntA	100	0	0
NVNT	a	5320	AntA	100	0	0
NVNT	n20	5260	AntA	100	0	0
NVNT	n20	5280	AntA	100	0	0
NVNT	n20	5320	AntA	100	0	0
NVNT	n40	5270	AntA	100	0	0
NVNT	n40	5310	AntA	100	0	0
NVNT	ac20	5260	AntA	100	0	0
NVNT	ac20	5280	AntA	100	0	0
NVNT	ac20	5320	AntA	100	0	0
NVNT	ac40	5270	AntA	100	0	0
NVNT	ac40	5310	AntA	100	0	0
NVNT	ac80	5290	AntA	100	0	0
NVNT	ax20	5260	AntA	100	0	0
NVNT	ax20	5280	AntA	100	0	0
NVNT	ax20	5320	AntA	100	0	0
NVNT	ax40	5270	AntA	100	0	0
NVNT	ax40	5310	AntA	100	0	0
NVNT	ax80	5290	AntA	100	0	0

Condition	Mode	Frequency (MHz)	Antenna	Duty Cycle (%)	Correction Factor (dB)	1/T (kHz)
NVNT	a	5500	AntA	100	0	0
NVNT	a	5580	AntA	100	0	0
NVNT	a	5700	AntA	100	0	0
NVNT	n20	5500	AntA	100	0	0
NVNT	n20	5580	AntA	100	0	0
NVNT	n20	5700	AntA	100	0	0
NVNT	n40	5510	AntA	100	0	0
NVNT	n40	5550	AntA	100	0	0
NVNT	n40	5670	AntA	100	0	0
NVNT	ac20	5500	AntA	100	0	0
NVNT	ac20	5580	AntA	100	0	0
NVNT	ac20	5700	AntA	100	0	0
NVNT	ac40	5510	AntA	100	0	0
NVNT	ac40	5550	AntA	100	0	0
NVNT	ac40	5670	AntA	100	0	0
NVNT	ac80	5530	AntA	100	0	0
NVNT	ax20	5500	AntA	100	0	0
NVNT	ax20	5580	AntA	100	0	0
NVNT	ax20	5700	AntA	100	0	0
NVNT	ax40	5510	AntA	100	0	0
NVNT	ax40	5550	AntA	100	0	0
NVNT	ax40	5670	AntA	100	0	0
NVNT	ax80	5530	AntA	100	0	0

Condition	Mode	Frequency (MHz)	Antenna	Duty Cycle (%)	Correction Factor (dB)	1/T (kHz)
NVNT	a	5745	AntA	100	0	0
NVNT	a	5785	AntA	100	0	0
NVNT	a	5825	AntA	100	0	0
NVNT	n20	5745	AntA	100	0	0
NVNT	n20	5785	AntA	100	0	0
NVNT	n20	5825	AntA	100	0	0
NVNT	n40	5755	AntA	100	0	0
NVNT	n40	5795	AntA	100	0	0
NVNT	ac20	5745	AntA	100	0	0
NVNT	ac20	5785	AntA	100	0	0
NVNT	ac20	5825	AntA	100	0	0
NVNT	ac40	5755	AntA	100	0	0
NVNT	ac40	5795	AntA	100	0	0
NVNT	ac80	5775	AntA	100	0	0
NVNT	ax20	5745	AntA	100	0	0
NVNT	ax20	5785	AntA	100	0	0
NVNT	ax20	5825	AntA	100	0	0
NVNT	ax40	5755	AntA	100	0	0
NVNT	ax40	5795	AntA	100	0	0
NVNT	ax80	5775	AntA	100	0	0



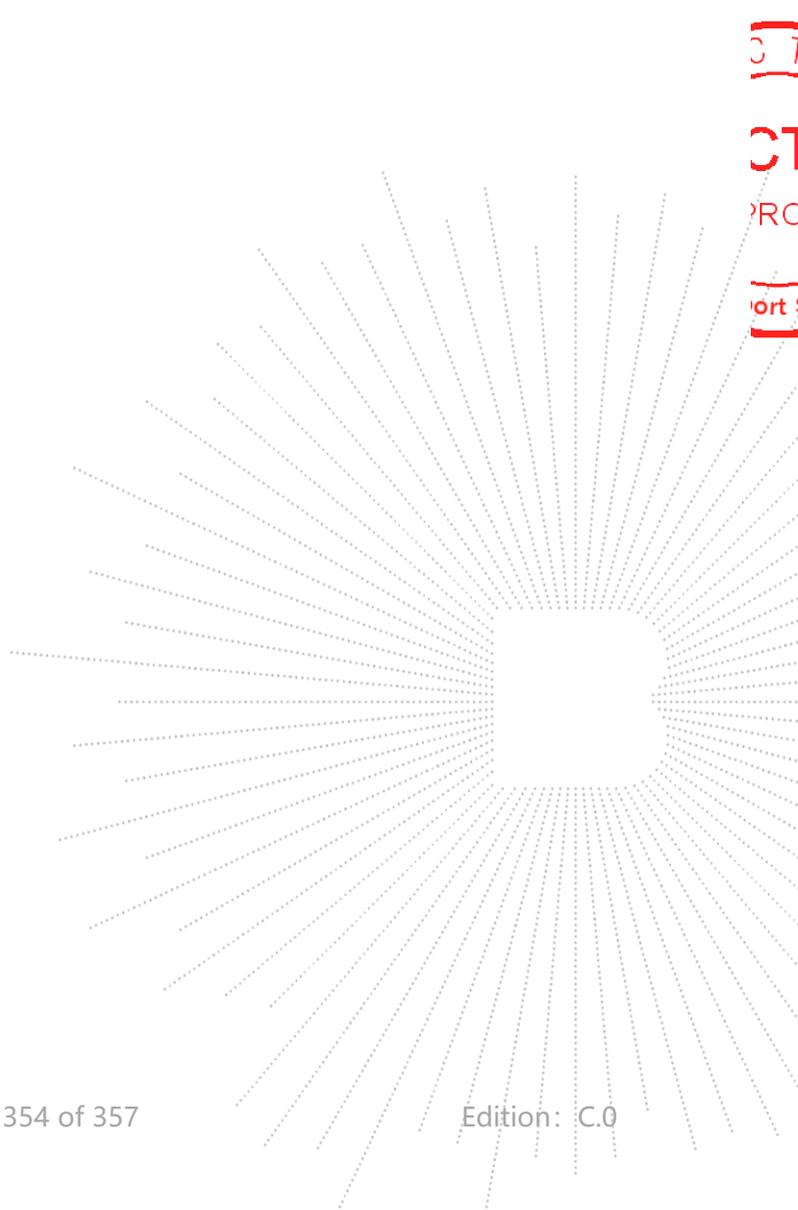
15. Antenna Requirement

15.1 Limit

15.203 requirement: For intentional device, according to 15.203: an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

15.2 Test Result

The EUT antenna is Internal antenna, fulfill the requirement of this section.



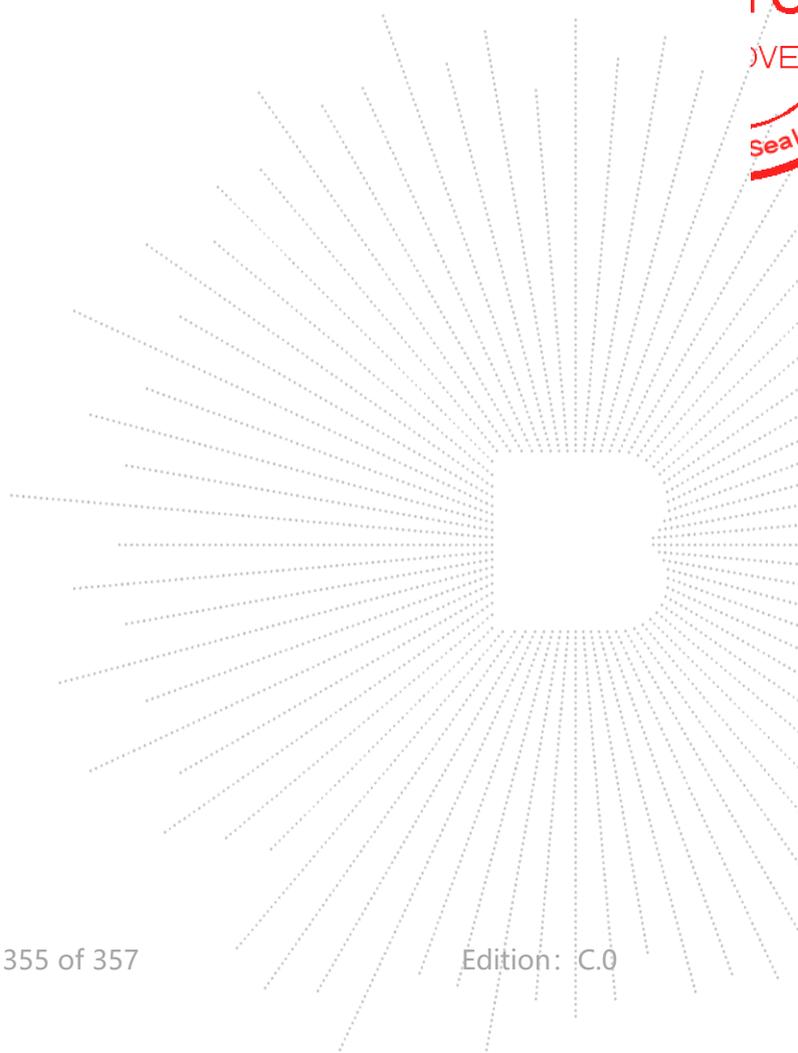
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16. EUT Test Setup Photographs

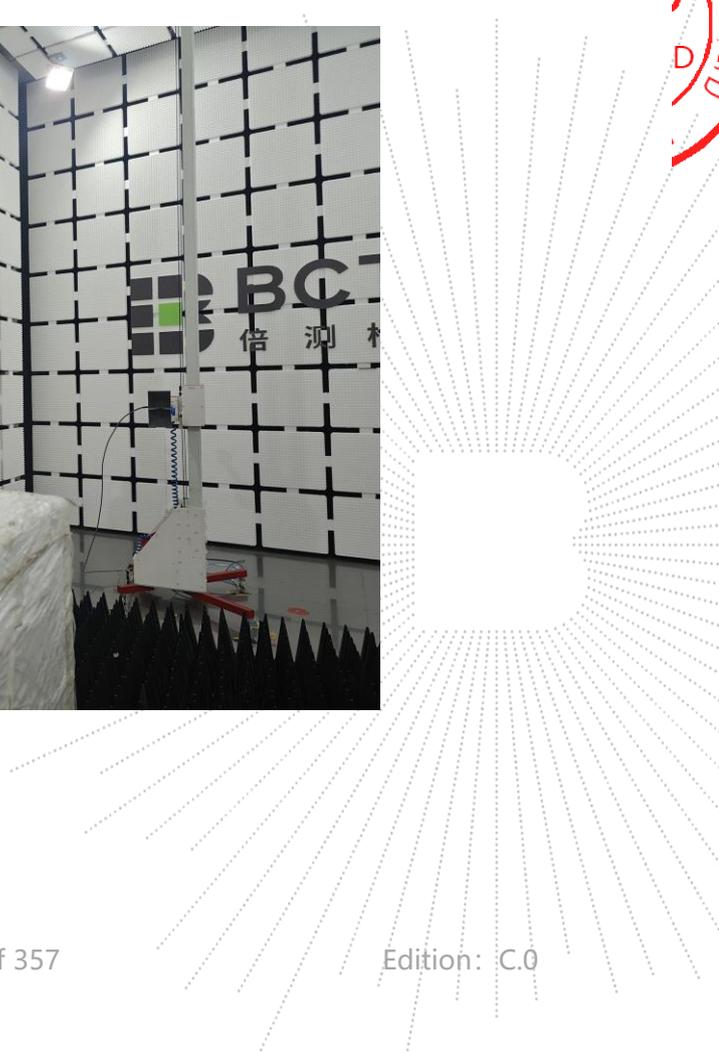
Conducted emissions



TEST
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Radiated Measurement Photos



STATEMENT

1. The equipment lists are traceable to the national reference standards.
2. The test report can not be partially copied unless prior written approval is issued from our lab.
3. The test report is invalid without the "special seal for inspection and testing".
4. The test report is invalid without the signature of the approver.
5. The test process and test result is only related to the Unit Under Test.
6. Sample information is provided by the client and the laboratory is not responsible for its authenticity.
7. The quality system of our laboratory is in accordance with ISO/IEC17025.
8. If there is any objection to this test report, the client should inform issuing laboratory within 15 days from the date of receiving test report.

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***** END *****

CO., LTD.

